

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEAttorney Docket No.  
8733.067.10

Application No.

LIST OF REFERENCES CITED BY  
APPLICANT  
(Use Several Sheets if Necessary)

Date: December 7, 2001

Applicant  
Jong Woo KIMFiling Date  
December 7, 2001Group  
TBAJCE26 U.S. PTO  
10/005125  
12/07/01

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL *	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>[Signature]</i>	6,031,590	2/2000	Kim	349	86	
<i>[Signature]</i>	6,016,174	1/2000	Endo et al.	349	43	
<i>[Signature]</i>	6,078,366	6/2000	Dohjo et al.	349	43	
<i>[Signature]</i>	5,541,748	7/1996	Ono et al.	359	59	
<i>[Signature]</i>	5,726,491	3/1998	Tajima et al.	257	668	
<i>[Signature]</i>	5,510,918	4/1996	Matsunaga et al.	359	88	
<i>[Signature]</i>	5,345,039	9/1994	Yamazaki	174	52.4	
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<i>[Signature]</i>	5,523,866	6/1996	Morimoto et al.	359	59	
<i>[Signature]</i>	5,572,346	11/1996	Sakamoto et al.	359	88	
<i>[Signature]</i>	5,187,604	2/1993	Taniguchi et al.			

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION
405 265 024	10/1993	JAPAN	
<del>2 090 036</del>	<del>6/1982</del>	<del>UNITED KINGDOM</del>	

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

*hance Schult*

DATE CONSIDERED

*8/10/02*

\*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

\*\*English-language abstract provided.